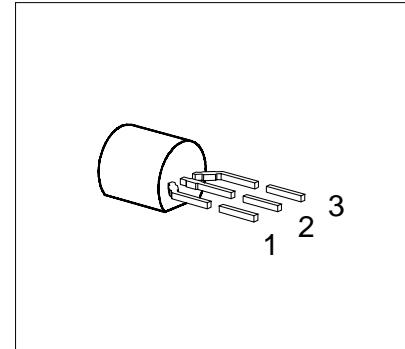


**SIPMOS® Small-Signal Transistor****BSS 135**

- $V_{DS}$  600 V
- $I_D$  0.080 A
- $R_{DS(on)}$  60  $\Omega$
- N channel
- Depletion mode
- High dynamic resistance
- Available grouped in  $V_{GS(th)}$



Type	Ordering Code	Tape and Reel Information	Pin Configuration			Marking	Package
			1	2	3		
BSS 135	Q67000-S237	E6325: 2000 pcs/carton; Ammopack	G	D	S	SS135	TO-92

**Maximum Ratings**

Parameter	Symbol	Values	Unit
Drain-source voltage	$V_{DS}$	600	V
Drain-gate voltage, $R_{GS} = 20 \text{ k}\Omega$	$V_{DGR}$	600	
Gate-source voltage	$V_{GS}$	$\pm 14$	
Gate-source peak voltage, aperiodic	$V_{gs}$	$\pm 20$	
Continuous drain current, $T_A = 42^\circ\text{C}$	$I_D$	0.080	A
Pulsed drain current, $T_A = 25^\circ\text{C}$	$I_{D \text{ puls}}$	0.24	
Max. power dissipation, $T_A = 25^\circ\text{C}$	$P_{\text{tot}}$	1.0	W
Operating and storage temperature range	$T_j, T_{\text{stg}}$	-55 ... +150	°C

Thermal resistance, chip-ambient (without heat sink)	$R_{thJA}$	$\leq 125$	K/W
DIN humidity category, DIN 40 040	-	E	-
IEC climatic category, DIN IEC 68-1	-	55/150/56	

**Electrical Characteristics**at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

**Static Characteristics**

Drain-source breakdown voltage $V_{GS} = -3\text{ V}$ , $I_D = 0.25\text{ mA}$	$V_{(BR)DSS}$	600	—	—	V
Gate threshold voltage $V_{DS} = 3\text{ V}$ , $I_D = 1\text{ mA}$	$V_{GS(\text{th})}$	— 1.8	— 1.5	— 0.7	
Drain-source cutoff current $V_{DS} = 600\text{ V}$ , $V_{GS} = -3\text{ V}$ $T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	$I_{DSS}$	—	—	100	nA
—		—	—	200	$\mu\text{A}$
Gate-source leakage current $V_{GS} = 20\text{ V}$ , $V_{DS} = 0$	$I_{GSS}$	—	10	100	nA
Drain-source on-resistance $V_{GS} = 0\text{ V}$ , $I_D = 0.01\text{ A}$	$R_{DS(\text{on})}$	—	40	60	$\Omega$

**Dynamic Characteristics**

Forward transconductance $V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\text{max}}$ , $I_D = 0.01\text{ A}$	$g_{fs}$	0.01	0.04	—	S
Input capacitance $V_{GS} = -3\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$	$C_{iss}$	—	110	150	pF
Output capacitance $V_{GS} = -3\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$	$C_{oss}$	—	8	12	
Reverse transfer capacitance $V_{GS} = -3\text{ V}$ , $V_{DS} = 25\text{ V}$ , $f = 1\text{ MHz}$	$C_{rss}$	—	3	5	
Turn-on time $t_{on}$ , ( $t_{on} = t_{d(on)} + t_r$ ) $V_{DD} = 30\text{ V}$ , $V_{GS} = -3\text{ V} \dots + 5\text{ V}$ , $R_{GS} = 50\text{ }\Omega$ , $I_D = 0.2\text{ A}$	$t_{d(on)}$	—	4	6	ns
	$t_r$	—	10	15	
Turn-off time $t_{off}$ , ( $t_{off} = t_{d(off)} + t_f$ ) $V_{DD} = 30\text{ V}$ , $V_{GS} = -3\text{ V} \dots + 5\text{ V}$ , $R_{GS} = 50\text{ }\Omega$ , $I_D = 0.2\text{ A}$	$t_{d(off)}$	—	15	20	
	$t_f$	—	20	30	

**Electrical Characteristics (cont'd)**at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

**Reverse Diode**

Continuous reverse drain current $T_A = 25^\circ\text{C}$	$I_S$	–	–	0.080	A
Pulsed reverse drain current $T_A = 25^\circ\text{C}$	$I_{SM}$	–	–	0.240	
Diode forward on-voltage $I_F = 0.16 \text{ A}, V_{GS} = 0$	$V_{SD}$	–	0.80	1.30	V

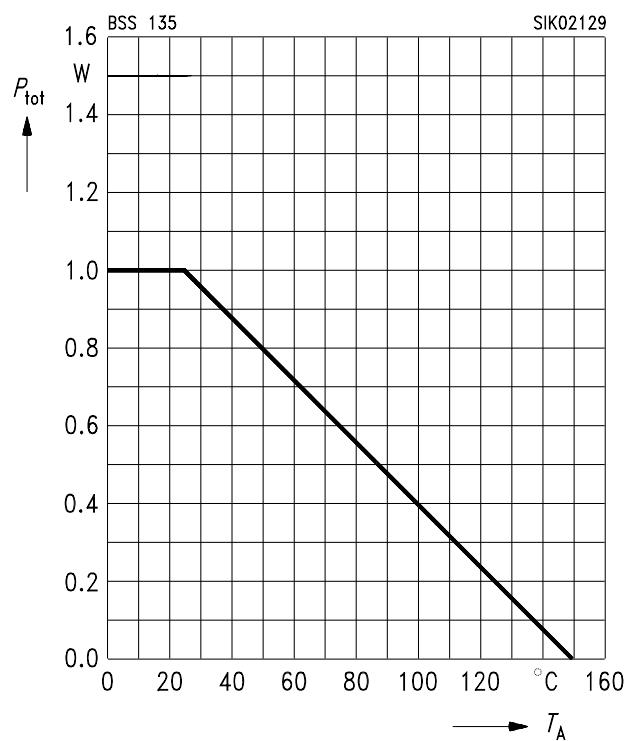
$V_{GS(\text{th})}$ Grouping	Symbol	Limit Values		Unit	Test Condition
		min.	max.		
Range of $V_{GS(\text{th})}$	$\Delta V_{GS(\text{th})}$	–	0.15	V	–
Threshold voltage selected in groups <sup>1)</sup> :	$V_{GS(\text{th})}$				$V_{DS1} = 0.2 \text{ V};$ $V_{DS2} = 3 \text{ V};$ $I_D = 1 \text{ mA}$
P		– 0.95	– 0.80	V	
R		– 1.08	– 0.93	V	
S		– 1.21	– 1.06	V	
T		– 1.34	– 1.19	V	
U		– 1.47	– 1.32	V	
V		– 1.60	– 1.45	V	
W		– 1.73	– 1.58	V	

- 1) A specific group cannot be ordered separately.  
Each reel only contains transistors from one group.

## Characteristics

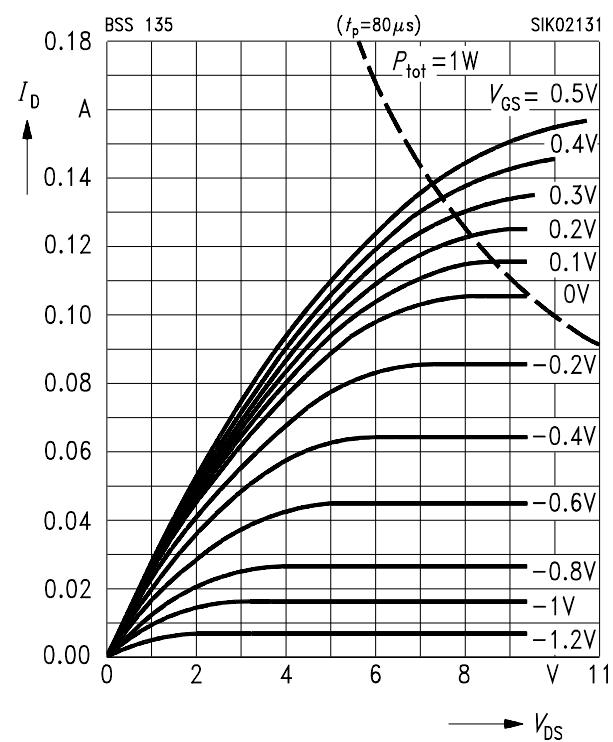
at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

**Total power dissipation**  $P_{\text{tot}} = f(T_A)$



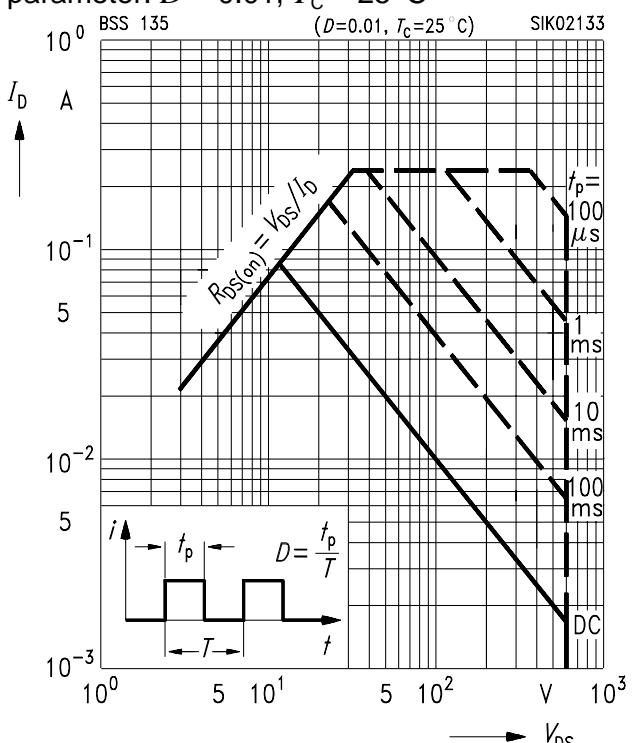
**Typ. output characteristics**  $I_D = f(V_{DS})$

parameter:  $t_p = 80 \mu\text{s}$



**Safe operating area**  $I_D = f(V_{DS})$

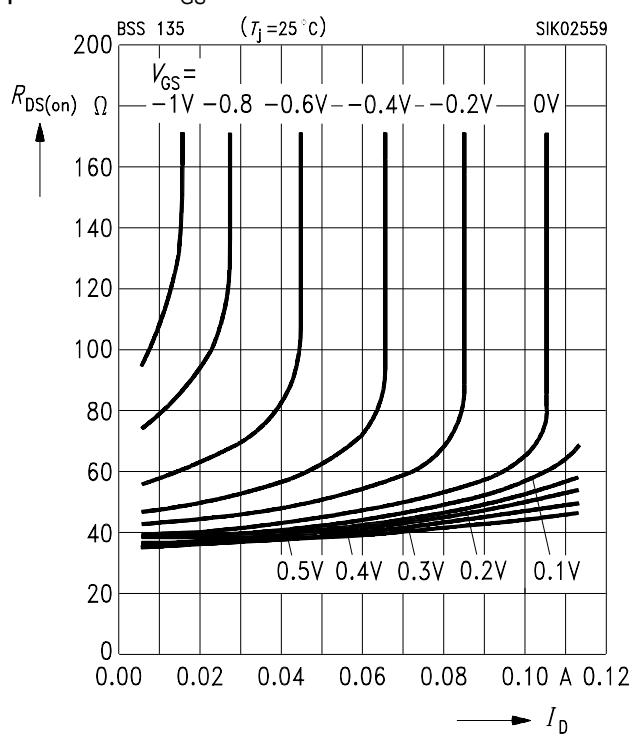
parameter:  $D = 0.01, T_c = 25^\circ\text{C}$



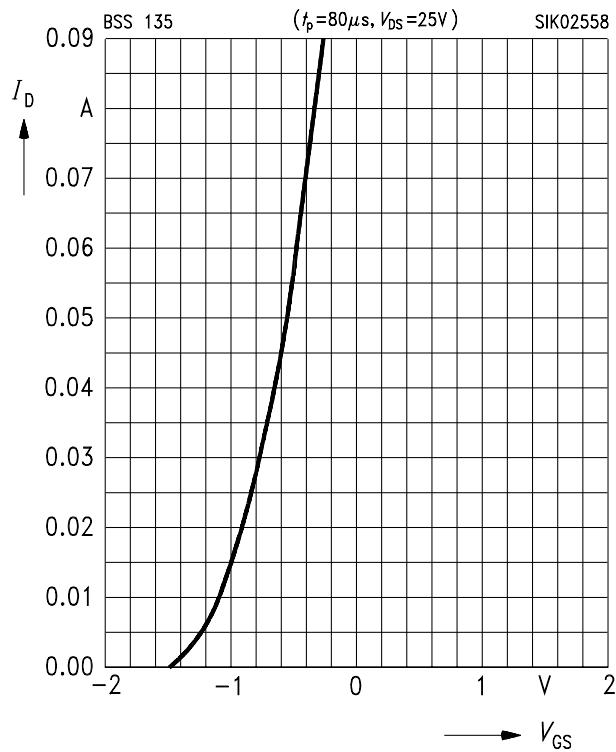
**Typ. drain-source on-resistance**

$R_{DS(on)} = f(I_D)$

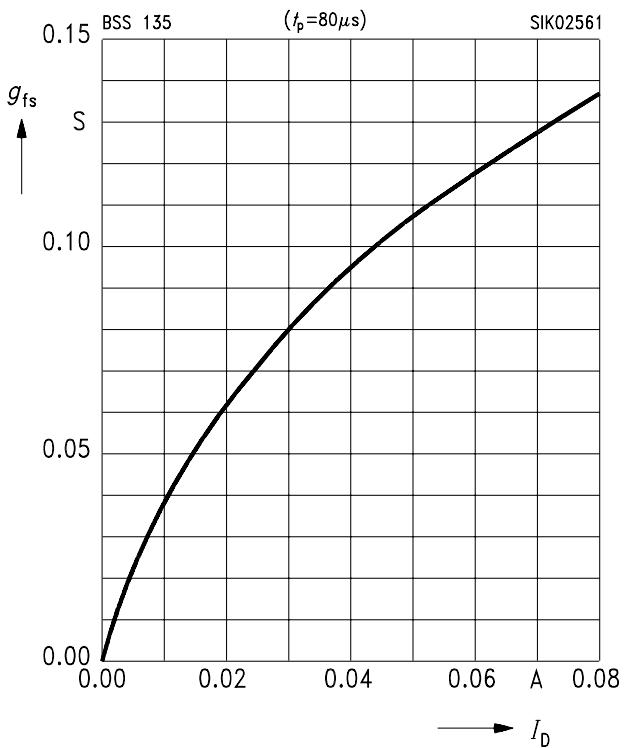
parameter:  $V_{GS}$



**Typ. transfer characteristics**  $I_D = f(V_{GS})$   
parameter:  $t_p = 80 \mu\text{s}$ ,  $V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\text{max.}}$

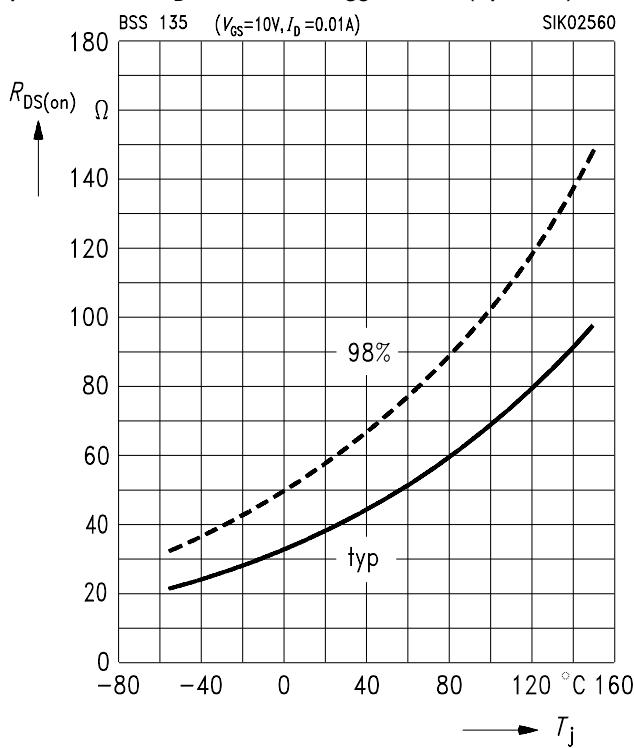


**Typ. forward transconductance**  $g_{fs} = f(I_D)$   
parameter:  $V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\text{max.}}$ ,  $t_p = 80 \mu\text{s}$

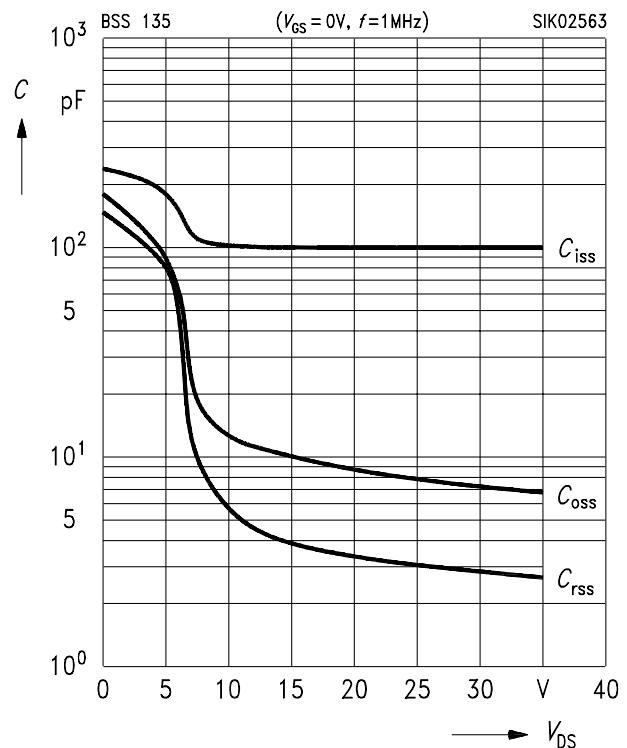


## Drain-source on-resistance

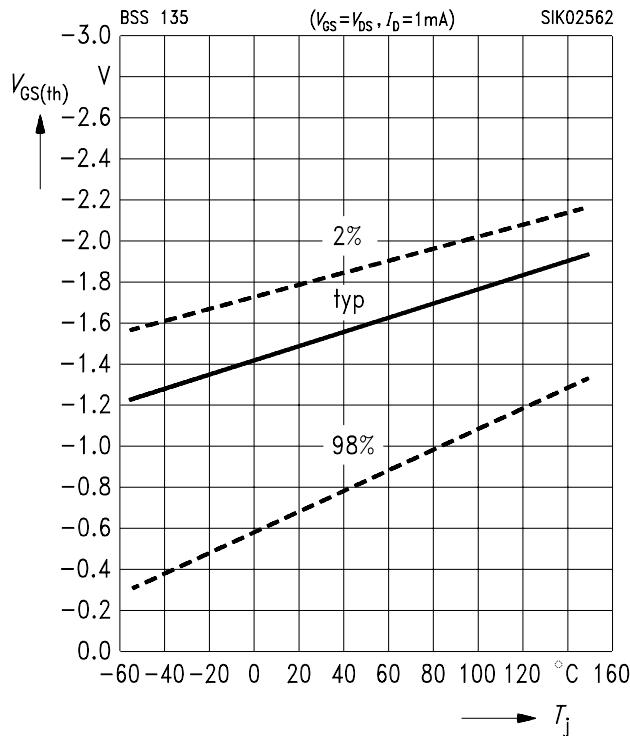
$R_{DS(\text{on})} = f(T_j)$   
parameter:  $I_D = 0.01 \text{ A}$ ,  $V_{GS} = 0 \text{ V}$ , (spread)



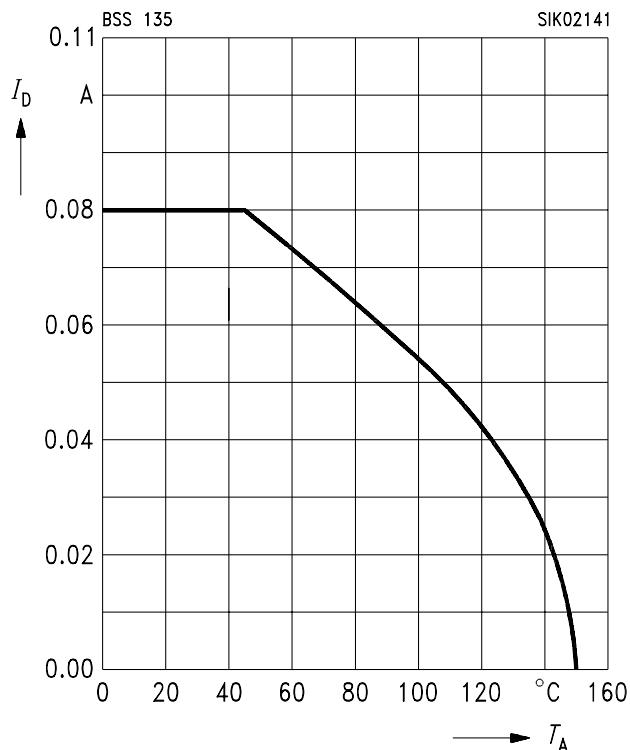
**Typ. capacitances**  $C = f(V_{DS})$   
parameter:  $V_{GS} = 0$ ,  $f = 1 \text{ MHz}$



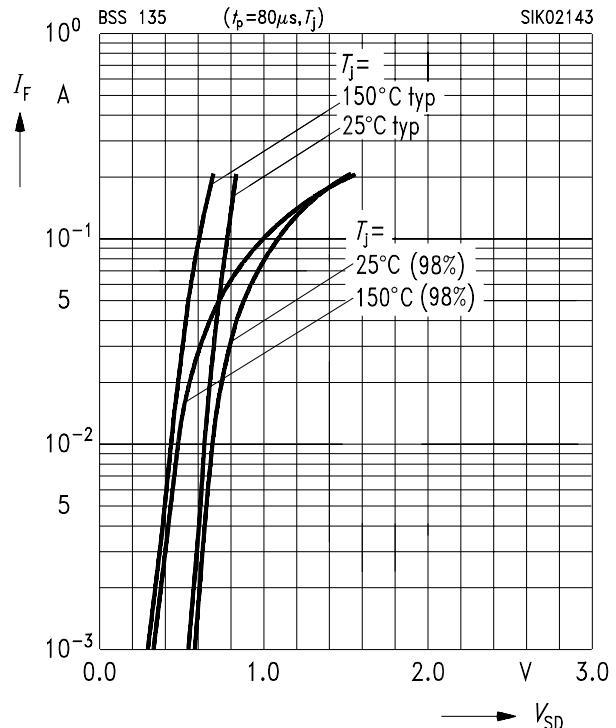
**Gate threshold voltage**  $V_{GS(th)} = f(T_j)$   
 parameter:  $V_{DS} = 3 \text{ V}$ ,  $I_D = 1 \text{ mA}$ , (spread)



**Drain current**  $I_D = f(T_A)$   
 parameter:  $V_{GS} \geq 3 \text{ V}$



**Forward characteristics of reverse diode**  
 $I_F = f(V_{SD})$   
 parameter:  $t_p = 80 \mu\text{s}$ ,  $T_j$  (spread)



**Drain-source breakdown voltage**  
 $V_{(BR)DSS} = b \times V_{(BR)DSS} (25^\circ\text{C})$

